Module title | Electron and Ion Microscopy
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Abbreviation | 11-EIM-Int-201-m01

Module coordinator | Managing Director of the Institute of Applied Physics
Module offered by | Faculty of Physics and Astronomy

ECTS | Method of grading | Only after succ. compl. of module(s)
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6 | numerical grade | --

Duration | Module level | Other prerequisites
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1 semester | graduate | --

Contents

Intended learning outcomes
The student has specific and immersed knowledge in electron and ion microscopy. He/she knows the theoretical and instrumental basics and principles of detectors and contrast mechanisms. He/she knows different modi of electron microscopy and their applications. He/she knows ongoing developments in this field.

Courses (type, number of weekly contact hours, language — if other than German)
V (3) + R (1)
Module taught in: English

Method of assessment (type, scope, language — if other than German, examination offered — if not every semester, information on whether module is creditable for bonus)
a) written examination (approx. 90 to 120 minutes) or
b) oral examination of one candidate each (approx. 30 minutes) or
c) oral examination in groups (groups of 2, approx. 30 minutes per candidate) or
d) project report (approx. 8 to 10 pages) or
e) presentation/talk (approx. 30 minutes).
If a written examination was chosen as method of assessment, this may be changed and assessment may instead take the form of an oral examination of one candidate each or an oral examination in groups. If the method of assessment is changed, the lecturer must inform students about this by four weeks prior to the original examination date at the latest.
Language of assessment: English

Allocation of places
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Additional information
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Referred to in LPO I (examination regulations for teaching-degree programmes)
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Module appears in
keinem Studiengang zugeordnet